Application/Control No. Reexamination 10/014,522 AKIWA, NAOTAKA **Notice of References Cited** Art Unit Examiner Page 1 of 1 Tran N. Nguyen 2834

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-5,030,864	07-1991	Van Hout et al.	310/67R
X	В	US-5,744,894	04-1998	Cho et al.	310/261
Х	С	US-5,654,600	08-1997	Nomura et al.	310/68B
х	D	US-4,430,603	02-1984	Muller, Rolf	318/254
X	E	US-6,316,856	11-2001	Kusaki et al.	310/90
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
х	N	JP-363077363	04-1988	Japan	Goto et al	310/49R
х	0	Jp-354099910	08-1979	Jajpan	Goto et al	310/254
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Applicant(s)/Patent Under